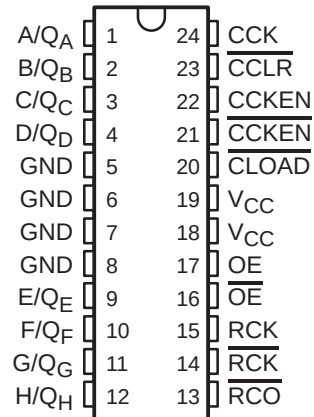


74ACT11593
8-BIT BINARY COUNTER
WITH PARALLEL-INPUT REGISTERS AND 3-STATE OUTPUTS

SCAS203 – JUNE 1992 – REVISED APRIL 1993

- Inputs Are TTL-Voltage Compatible
- Parallel Register Inputs/Binary Counter/3-State Outputs
- Counter Has Direct Overriding Load and Clear
- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin V_{CC} and GND Configurations Minimize High-Speed Switching Noise
- **EPIC™** (Enhanced-Performance Implanted CMOS) 1- μ m Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic Small-Outline Packages and Standard Plastic 300-mil DIPs

DW OR NT PACKAGE
(TOP VIEW)



description

The 74ACT11593 contains eight multiplexed parallel I/Os with 3-state output capability and an 8-bit storage register that feeds an 8-bit binary counter. Both the register and the counter have individual positive-edge triggered clocks.

The function tables show the operation of the counter clock-enable ($\overline{CCKEN}$, $\overline{CCKEN}$) and output-enable ($\overline{OE}$, $\overline{OE}$) inputs.

The counter input has direct load and clear functions. A low-going $\overline{RCO}$ pulse is obtained when the counter reaches the hex word FF.

Expansion is easily accomplished for two stages by connecting $\overline{RCO}$ of the first stage to $\overline{CCKEN}$ of the second stage. Cascading for larger count chains is accomplished by connecting $\overline{RCO}$ of each stage to CCK of the following stage.

The 74ACT11593 is characterized for operation from –40°C to 85°C.

Function Tables

COUNTER CLOCK ENABLE

INPUTS		OUTPUTS A/Q _A THRU H/Q _H
CCKEN	$\overline{CCKEN}$	
L	L	Disable
L	H	Disable
H	L	Enable
H	H	Disable

OUTPUT ENABLE

INPUTS		OUTPUTS A/Q _A THRU H/Q _H
OE	$\overline{OE}$	
L	L	Input mode
L	H	Input mode
H	L	Output mode
H	H	Input mode

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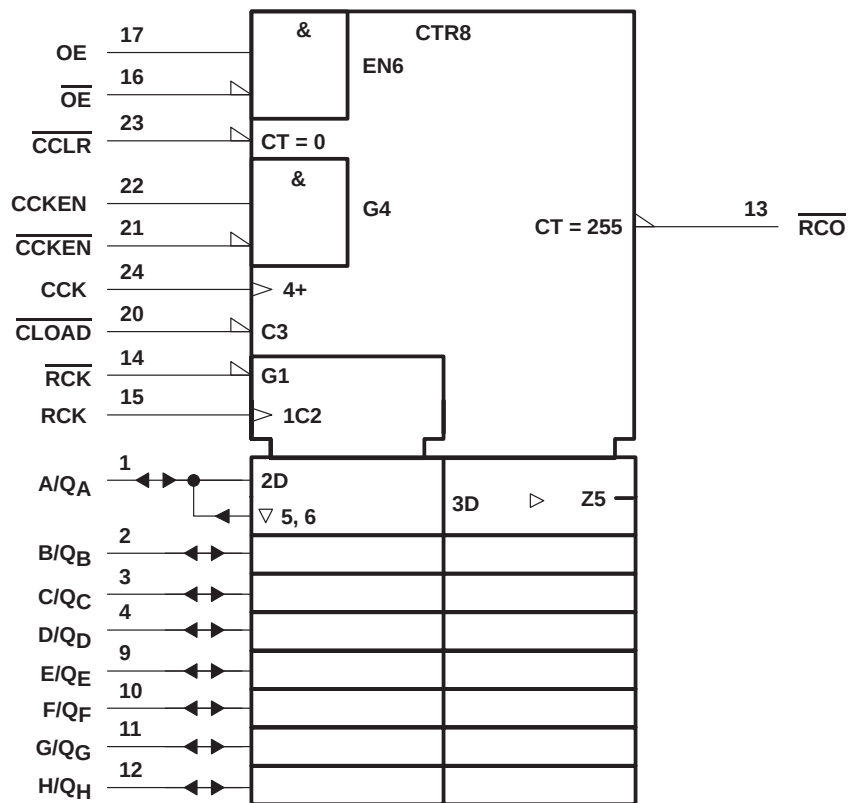
74ACT11593

8-BIT BINARY COUNTER

WITH PARALLEL-INPUT REGISTERS AND 3-STATE OUTPUTS

SCAS203 – JUNE 1992 – REVISED APRIL 1993

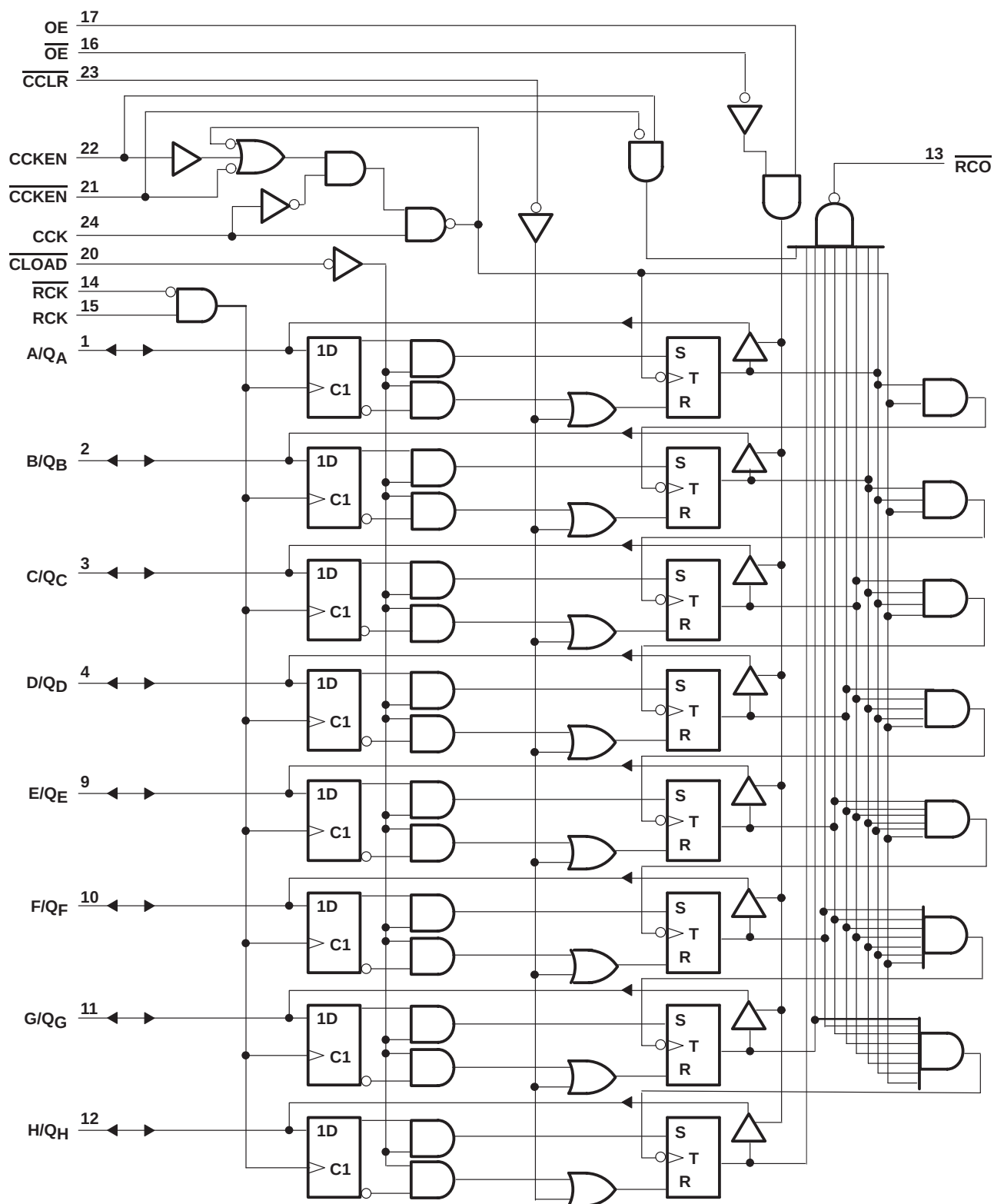
logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

74ACT11593
8-BIT BINARY COUNTER
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SCAS203 – JUNE 1992 – REVISED APRIL 1993

logic diagram (positive logic)



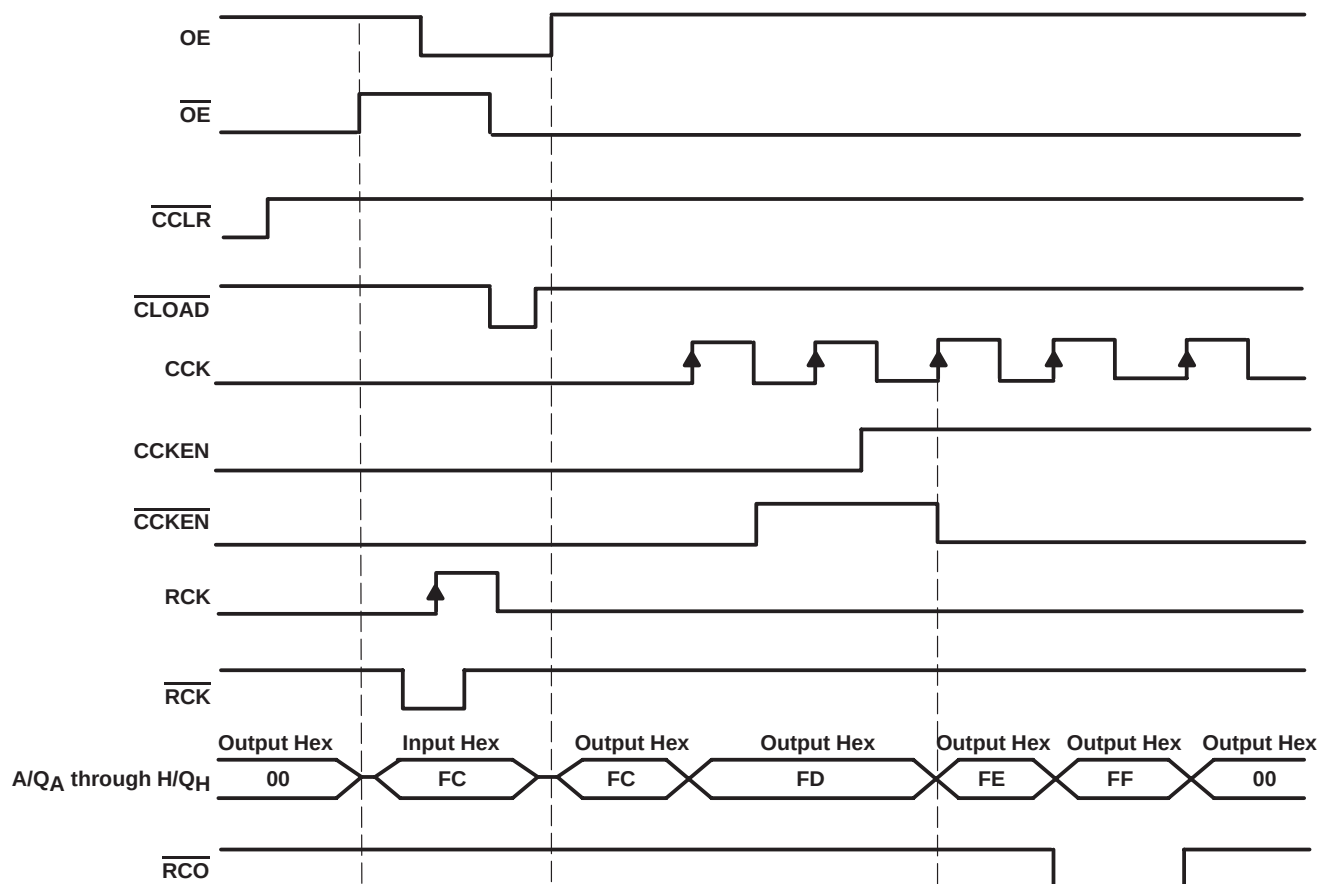
74ACT11593

8-BIT BINARY COUNTER

WITH PARALLEL-INPUT REGISTERS AND 3-STATE OUTPUTS

SCAS203 – JUNE 1992 – REVISED APRIL 1993

typical operating sequence



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC}	–0.5 V to 7 V
Input voltage range, V_I (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Output voltage range, V_O (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through V_{CC} or GND	±225 mA
Storage temperature range	–65°C to 150°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

74ACT11593
8-BIT BINARY COUNTER
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SCAS203 – JUNE 1992 – REVISED APRIL 1993

recommended operating conditions (see Note 2)

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage			0.8	V
V_I	Input voltage	0	V_{CC}		V
V_O	Output voltage	0	V_{CC}		V
I_{OH}	High-level output current			-24	mA
I_{OL}	Low-level output current			24	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0		10	ns/V
T_A	Operating free-air temperature	-40		85	°C

NOTE 2: Unused or floating inputs must be held high or low.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V_{CC}	$T_A = 25^\circ\text{C}$			MIN	MAX	UNIT
			MIN	TYP	MAX			
V_{OH}	$I_{OH} = -50\ \mu\text{A}$	4.5 V	4.4			4.4		V
		5.5 V	5.4			5.4		
	$I_{OH} = -24\ \text{mA}$	4.5 V	3.94			3.8		
		5.5 V	4.94			4.8		
	$I_{OH} = -75\ \text{mA}^\dagger$	5.5 V				3.85		
V_{OL}	$I_{OL} = 50\ \mu\text{A}$	4.5 V			0.1		0.1	V
		5.5 V			0.1		0.1	
	$I_{OL} = 24\ \text{mA}$	4.5 V			0.36		0.44	
		5.5 V			0.36		0.44	
	$I_{OL} = 75\ \text{mA}^\dagger$	5.5 V					1.65	
I_I	$V_I = V_{CC}$ or GND	5.5 V			± 0.1		± 1	μA
I_{OZ}	$V_O = V_{CC}$ or GND	5.5 V			± 0.5		± 5	μA
I_{CC}	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		80	μA
$\Delta I_{CC}^\ddagger$	One input at 3.4 V, Other inputs at V_{CC} or GND	5.5 V			0.9		1	mA
C_i	$V_I = V_{CC}$ or GND	5 V		3.5				pF
C_{io}	$V_O = V_{CC}$ or GND	5 V		12.5				pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

[‡] This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC} .

74ACT11593
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SCAS203 – JUNE 1992 – REVISED APRIL 1993

timing requirements over recommended operating free-air temperature range, $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$ (unless otherwise noted) (see Figure 1)

			T _A = 25°C		MIN	MAX	UNIT
			MIN	MAX			
f _{clock}	Clock frequency, CCK or RCK		52		52		MHz
t _w	Pulse duration	CCK high or low	9.6		9.6		ns
		RCK high or low	5.8		5.8		
		CCLR low	7.6		7.6		
		CLOAD low	6.2		6.2		
t _{su}	Setup time	CCKEN low before CCK↑	3.6		3.6		ns
		CCKEN high before CCK↑	4		4		
		CCLR high before CCK↑	1.2		1.2		
		CLOAD high before CCK↑	5.1		5.1		
		RCK↑ before CLOAD↑↑	7.4		7.4		
		Data A thru H before RCK↑	2.4		2.4		
t _h	Hold time	Data A thru H after RCK↑	1.2		1.2		ns
		All others	0.8		0.8		

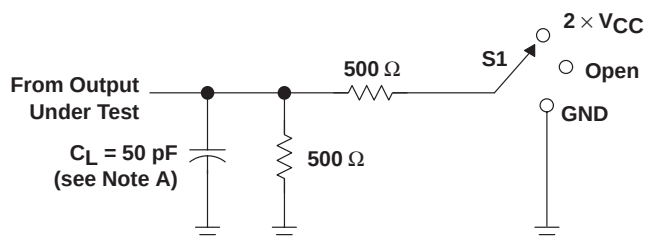
switching characteristics over recommended operating free-air temperature range,
 $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T _A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
f _{max}			52			52		MHz
t _{PLH}	CCK	Q	5.6	10.2	13.3	5.6	15.1	ns
t _{PHL}			5.8	10.3	13.3	5.8	15	
t _{PLH}	$\overline{\text{CLOAD}}$	Q	5.5	12	16.9	5.5	19.1	ns
t _{PHL}			5.8	13.5	19.4	5.8	21.7	
t _{PHL}	$\overline{\text{CCLR}}$	Q	5	10.4	14.3	5	16	ns
t _{PZH}	OE	Q	5.9	10.9	14.3	5.9	16.3	ns
t _{PZL}			5.9	11.1	14.8	5.9	16.9	
t _{PZH}	$\overline{\text{OE}}$	Q	4.9	10.4	14.4	4.9	16.5	ns
t _{PZL}			5.1	10.7	15	5.1	17	
t _{PHZ}	OE	Q	5.3	9	11.8	5.3	12.9	ns
t _{PLZ}			6.2	10.2	13.1	6.2	14.4	
t _{PHZ}	$\overline{\text{OE}}$	Q	5.6	8.6	10.7	5.6	11.6	ns
t _{PLZ}			6.4	9.9	12	6.4	13.3	
t _{PLH}	CCK	$\overline{\text{RCO}}$	4.9	9.2	12.1	4.9	13.7	ns
t _{PHL}			5.8	10.9	14.3	5.8	16.3	
t _{PLH}	$\overline{\text{CLOAD}}$	$\overline{\text{RCO}}$	4.6	9.6	13.3	4.6	15	ns
t _{PHL}			7.1	13.6	18.5	7.1	21	
t _{PLH}	$\overline{\text{CCLR}}$	$\overline{\text{RCO}}$	5.1	10.3	14.5	5.1	16.2	ns
t _{PLH}	RCK	$\overline{\text{RCO}}$	6.7	12	15.6	6.7	17.7	ns
t _{PHL}			7.5	13.6	17.8	7.5	20.2	

operating characteristics, $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$

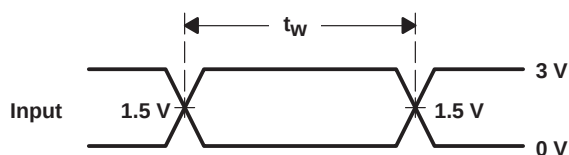
PARAMETER		TEST CONDITIONS	TYP	UNIT
C_{pd} Power dissipation capacitance	Outputs enabled	$C_L = 50\text{ pF}$, $f = 1\text{ MHz}$	61	pF
	Outputs disabled		15	

PARAMETER MEASUREMENT INFORMATION

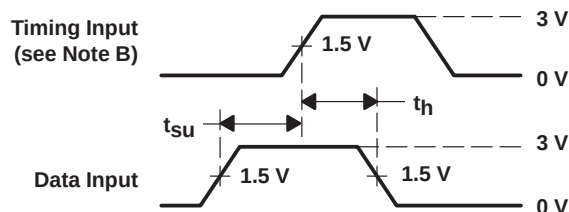


LOAD CIRCUIT

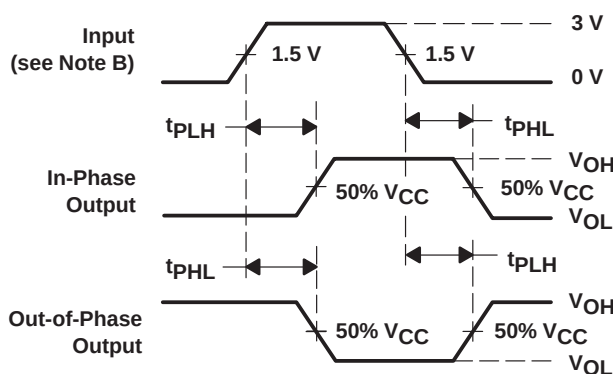
TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	2 $\times V_{CC}$
t_{PHZ}/t_{PZH}	GND



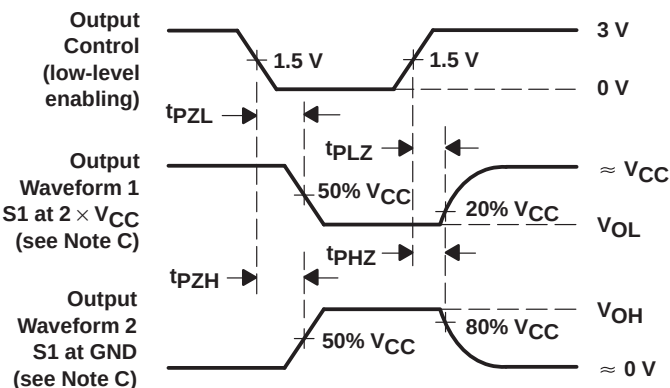
VOLTAGE WAVEFORMS



VOLTAGE WAVEFORMS



VOLTAGE WAVEFORMS



VOLTAGE WAVEFORMS

NOTES: A. C_L includes probe and jig capacitance.

B. All input pulses are supplied by generators having the following characteristics: $PRR \leq 10\text{ MHz}$, $Z_O = 50\text{ }\Omega$, $t_r = 3\text{ ns}$, $t_f = 3\text{ ns}$.

C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.

Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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